

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10045467	CHAN ET AL.
	Examiner	Art Unit
	Jorgensen, Leland R	2675

SEARCHED

Class	Subclass	Date	Examiner
349	151		
349	33		
349	121, 128-130		
349	139		
345	93, 94		
345	99-103		
349	141-143		
345	87-103, 204	5/7/07	LL

SEARCH NOTES

Search Notes	Date	Examiner
East Search	5/7/07	LL

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner